


<b>Search Notes</b>  	<b>Application/Control No.</b>  10552312	<b>Applicant(s)/Patent Under Reexamination</b>  HAMADA, TAKESHI
	<b>Examiner</b>  David E Bochna	<b>Art Unit</b>  3679

SEARCHED			
Class	Subclass	Date	Examiner
285	124.5, 124.3, 124.4	1/18/08	DB
285	363, 364, 365, 366, 367, 368, 336, 370	8/27/08	DB

SEARCH NOTES		
Search Notes	Date	Examiner
Updated the previous search	8/27/08	DB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
285	124.5, 124.4, 336, 370	8/27/08	DB

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